Application/Control No. Applicant(s)/Patent Under Reexamination 10/764,816 WU ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Kan Yuen 2616 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-2004/0136329 A1 07-2004 Duvaut et al. Α 370/252 US-В US-С

FORFION	DATENTO	OCUMENTS

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